

# AMP2\_3

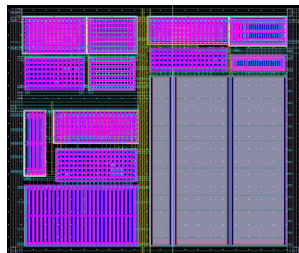
**Smart Amplifier:** Ultra-Low-Power, Low-Noise, High-Gain, Near Rail-To-Rail input/output (I/O), Moderate-Speed Buffer Amplifier. Proof of silicon with typical/preliminary measurements available.

Please contact [sales@ailinear.com](mailto:sales@ailinear.com) for more information & ordering specific evaluation.

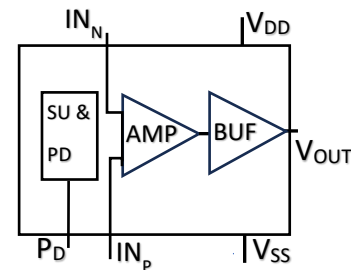
Parameter	Typical Spec	Typical Conditions: $V_{DD}=1V$ , Temperature = 27C, unless otherwise stated
$I_{DD}$ (nA)	~73	sAMP Gain=1 & $V_{INPUT} \approx 0.5 V_{DD}$
$V_{DD}$ Low (v)	~0.8	$V_{DD}$ sweep 0v→1v
$V_{DD}$ High (v)	~1	$V_{DD}$ sweep 0v→1v
$V_{OFFSET}$ (mv)	~±5	sAMP Gain=1 & $V_{INPUT} \approx 0.5 V_{DD}$
I/O Swing to Rails (mv)	~±25	$V_{DD}$ sweep 0v→2v
Gain (dB)	~90	sAMP Gain=1 & $V_{INPUT} \approx 0.5 V_{DD}$ . Tested at higher frequencies and extrapolated to DC
PSRR (dB)	~80	sAMP Gain=1 & $V_{INPUT} \approx 0.5 V_{DD}$ . Tested at higher frequencies and extrapolated to DC
Noise ( $\mu v/vHz$ )	~7	$V_{OUT}$ noise 10Hz. sAMP Gain=1 & $V_{INPUT} \approx 0.5 V_{DD}$ .
$f_u$ (KHz)	~7	sAMP Gain=1 & 10mv p-p $V_{INPUT}$ mid $\approx 0.5 V_{DD}$
SR (v/ms)	~170	sAMP Gain=1 & 0.8v p-p pulse $V_{INPUT}$ mid $\approx 0.5 V_{DD}$
$t_s$ ( $\mu s$ )	~20	sAMP Gain=1 & 0.8v p-p pulse $V_{INPUT}$ mid $\approx 0.5 V_{DD}$
Cell Size ( $\mu m \times \mu m$ )	~115x100	
TSMC Process Node (nm)	65	

\*See Disclaimers\*

sAMP Cell Layout



sAMP Block Diagram



## Features:

- The sAMP's  $I_Q \approx f(PTAT) \rightarrow$  improved dynamic response's TC
- The  $I_{DD} \approx f(I_Q) \approx f(\mu_{NMOS}) \approx f(R_{NMOS}) \neq f(V_{TH}) \rightarrow I_{DD}$  less sensitive to manufacturing variations
- The  $R_{NMOS}$  inside PTAT voltage loop coupled to  $V_{SS}$  for less sensitivity to  $V_{DD}$  noise
- At ultra-low  $I_{DD}$ , utilizing standard cascoded current mirrors in FCTA stage
- The sAMP with internal class AB (push-pull) buffer (BUF) can drive larger loads (e.g. 10s of mega  $\Omega$ s) in a low-power SoC